

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination NAKANO, TAKEHIKO	
		Examiner April Y. Shan	Art Unit 2135	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,726,100	04-2004	Lauper et al.	235/380
	B	US-			
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	D	US-			
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	K	US-			
	L	US-			
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**NON-PATENT DOCUMENTS**

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